

<b>Notice of References Cited</b>	Application/Control No. 10/813,087	Applicant(s)/Patent Under Reexamination OCHIAI ET AL.	
	Examiner Hana A. Sanei	Art Unit 2879	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0047970	04-2002	Ono et al.	349/122
*	B	US-6,356,331	03-2002	Ono et al.	349/141
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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